



Article Effect of Dangling Bonds on De-Poling Time for Polymeric Electric Field Optical Sensors

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Abstract: This paper investigates the possible chemical changes in polydimethylsiloxane (PDMS) caused by two different techniques of fabrication for ultra-sensitive electric field optical sensors. The sensing element is a micro-sphere made from 60:1 PDMS (60 parts base silicon elastomer to one part polymer curing agent by volume). The measurement principle is based on the morphology dependent resonances (MDR) shifts of the micro-sphere. We present the effects of curing and poling of polymer micro-spheres used as optical sensors. The degree of curing leads to changes in the de-poling time which results from dangling bonds in the polymeric chains. Consequently, the longevity of the sensitivity of the sensor can extended by two orders of magnitude. An analysis is carried out along with preliminary experiments to investigate that behavior.

Keywords: morphology dependent resonances; dangling bonds; micro-resonators; electric field sensor; polymeric optical sensors; polarization locking; polymeric cantilevers; electrtrostriction force

1. Introduction

In this paper, optical cavities depending on morphology-dependent resonances (MDR) will be used to sense the applied electric field. MDR are optical modes of dielectric cavities, such as toroids, spherical shells, and spheres. A tunable laser is used to excite such modes. The light is coupled tangentially from the laser into the sensing element using an optical fiber [1]. The optical modes are monitored as sharp dips in the transmission spectrum through the photodiode end of the fiber. These modes are also denoted as the morphology-dependent resonant MDR modes due to their high sensitivity to morphological variations (for example the dimension, shape, or refractive index) of the optical sensors. By monitoring the MDR shifts, these cavities can be used to accurately sense and measure various phenomena of the surrounding environment [2–4].

Geometric optics can easily describe the MDR phenomenon [5,6]. This description is legal at the first order approximation when the wavelength of the laser is much smaller compared to the size of the optical sensor. From the geometric point of view, light coupled at a grazing angle into a microsphere whose refractive index is larger than that of the surrounding medium circumnavigates through the interior surface of the sphere over the total internal reflection (as shown in Figure 1) and returns in phase. The condition for optical resonance is $2\pi Rn_0 \approx l\lambda$, where λ is the vacuum wavelength of the light (supplied by a laser), *l* is an integer, *R* is the sphere radius, and n_0 is the sphere's refractive index. When the sphere is subjected to the external electric field, its morphology changes (elastic deformation)

due to the electrostriction effect. This, in turn, causes a perturbation of both the radius (ΔR) and refractive index (Δn), leading to a shift in the optical resonance (MDR), as follows:

$$\frac{\Delta\lambda}{\lambda} = \frac{\Delta n_0}{n_0} + \frac{\Delta R}{R} \tag{1}$$

The MDR is very sensitive to any change in its radius or index of refraction and, hence, can be tuned by causing a very small change in the measurand of the surrounding. Any small change in the surroundings can be measured by monitoring its MDR shifts due to the very high optical *Q*-factors that can exhibit the higher *Q*-factor indicates a lower rate of energy loss relative to the stored energy of the resonator [7,8].

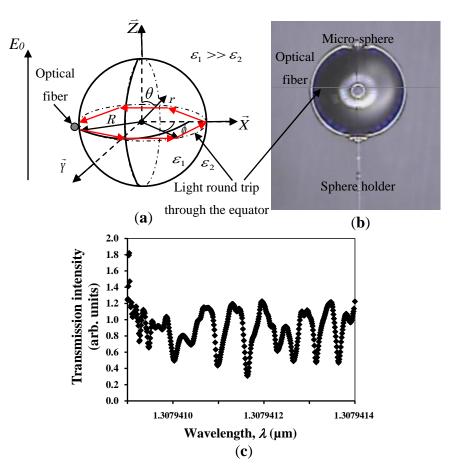


Figure 1. Microsphere coupled with an optical fiber: (**a**) schematic; (**b**) photograph; and (**c**) typical transmission spectra trough the sphere-coupled fiber.

Figure 1 shows the optical setup for the proposed sensor in the present paper. Once the light is coupled to the cavity through the tapered section in the optical fiber the MDR could be seen as sharp dips in the transmission spectrum, as seen in Figure 1c.

Recently, an MDR-based photonic electric field sensor was demonstrated [9–13]. The theory of operation is based on changing the radius of the cavity due to the electrostriction effect. The external electric field will perturb the sensor's geometry leading to a shift in its MDR.

Electric field detections with high resolution may offer a more physiological means of neural modulation for prosthetic purposes than previously possible [14].

2. Experimental Investigation

2.1. Measurement Approach

The theory of operation depends on the morphology-induced shift of the optical sensors. In recent years, different applications used the proposed theory in sensing algorithms. The high quality factor, $Q = \lambda/\delta\lambda$ (where λ is the laser wavelength (~1.312 µm) and $\delta\lambda$ is the resonance line width) is the main reason behind using the MDR micro-optical cavity in several applications. *Q*-factors can range from ca. 10⁵ to 10⁸, as reported in the literature [15]. Tangentially coupling the light to the cavity is one of the easiest methods to let the light start to interrogate through the total internal reflection of the cavity [12,16–18], as shown in Figure 1a. Recently, MDR micro-cavities have been used in applications including spectroscopy [19,20], micro-cavity laser technology [21], optical communications (switching [22], filtering [23], and multiplexing [24]), and sensor technologies [3,4,8,12,15,17,25–33]. In this paper, the electric field imposes a force on the dielectric microsphere (commonly referred to as the electrostriction effect) leading to the deformation of the sphere. The deformation is measured by tracking the MDR shifts of the sphere.

2.2. Experimental Opto-Electronics Setup

Figure 2 shows schematic for the interaction between the optical sensors and its signal processing. A single-mode optical fiber is used to obtain the output of a distributed feedback laser diode (DFB) with a nominal wavelength of ca. 1312 nm and power of 5 mW. A 90%:10% splitter is used to split the light intensity between the MDR sensor and the reference signal through the photo diode (PD), respectively. As is known, the wavelength of the light can be affected by temperature, so the laser controller is used to maintain the laser temperature constant during the measurements. Typically, a saw-tooth signal driven from the function generator is used to tune the light. All these gadgets will be sampled and monitored through a 16-bit data acquisition card (DAQ) and processed by a host personal computer (PC). By monitoring any shifts in the transmission spectrum of the resonance shifts in real-time, any perturbation around the cavity's environment can be measured.

The external electric field will exert such a force on the polar direction of the cavity and compress it in the direction perpendicular to the optical fiber. Two electrodes made from brass are connected to a function generator in order to generate a harmonic electric field. Typically, the optical cavity would be laying between these two parallel electrodes as shown in Figure 3. Note that the polarization of an optical mode in the sphere is in a plane orthogonal to the light propagation and the observed resonances can be TE or TM modes. For large circumferential mode numbers ($l = \lambda/2\pi Rn_0 >> 1$, where R and n_0 are the sphere radius and refractive index), the effect of mode polarization is negligible [11]. The optical *Q*-factor for the resonance shown in this paper is ca. 3×10^5 . Two different techniques are used to fabricate the sensing element; the first technique is called curing while poling (CWP) and the second one is called curing then poling (CTP).

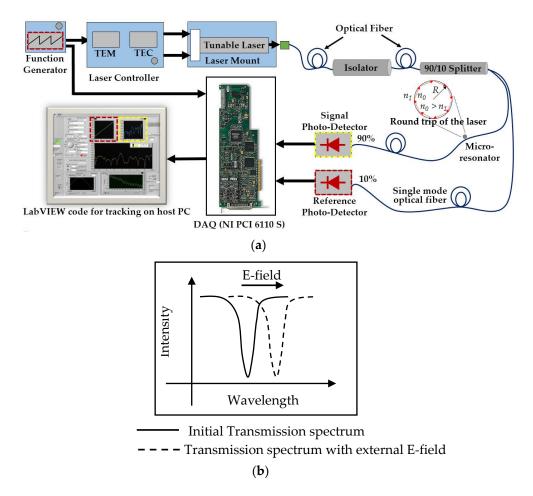


Figure 2. Typical (**a**) schematic of the opto-electonic setup for the MDR sensor system; and (**b**) schematic transmission spectrum for a spherical resonator.

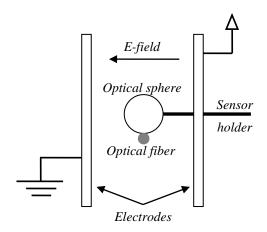


Figure 3. Typical schematic for the experimental setup.

2.3. Fabrication of Sensing Elements

For both mentioned techniques (curing while poling and curing then poling) we using micro-optical cavities made from polymeric material. By dipping a piece of optical fiber in a bath of 60 parts of polydimethylsiloxane (PDMS) with one part polymer curing agent by volume, the cavities would be seen as spheres on top of these optical fibers. Due to the surface tension and the gravity the micro-optical cavities formed spherical shapes acting as an optical sensors. In order to get the light out

of the optical fiber to become tangentially coupled with the micro-cavity and circumnavigate through the total internal reflection, the optical fiber should be heated using a micro torch and stretched at the same time to create a tapered section [34] in the middle part of the optical fiber with a ~10 to 20 μ m in diameter. The sensor size kept close for both techniques CTP and CWP which is ca. 600 μ m in diameter. In the first technique—curing then poling—typically we cure the 60:1 PDMS sensors in the oven for almost 4 h at 65 °C. After the sphere has been cured, it is poled for two hours in a uniform electric field of ca. 1 MV/m to develop surface charges so as to increase the electric field-induced force on it [16]. However, in the other technique—curing while poling—the sensor is cured at 65 °C and poled with ca. 1 MV/m at the same time, as seen in Figure 4, for almost 4 h. After we finished preparing the sensor for measurement, the electric field is generated by two brass plates connected to a function generator. The sphere is then placed between the electrodes (refer to Figure 3) and subjected to a harmonic external electric field by supplying voltage to the plates from the function generator. Then the comparison between both techniques using almost the same size of sensors (ca. 600 μ m

diameter) was performed and we kept all factors fixed, except the fabrication methods.

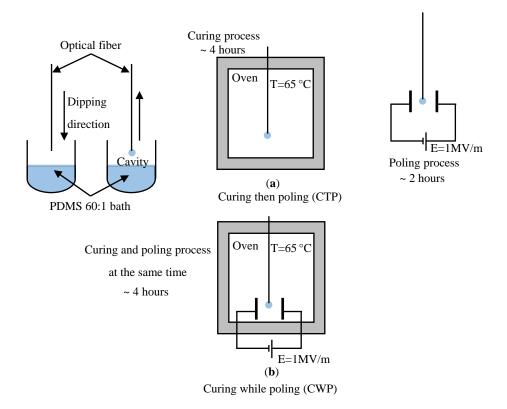
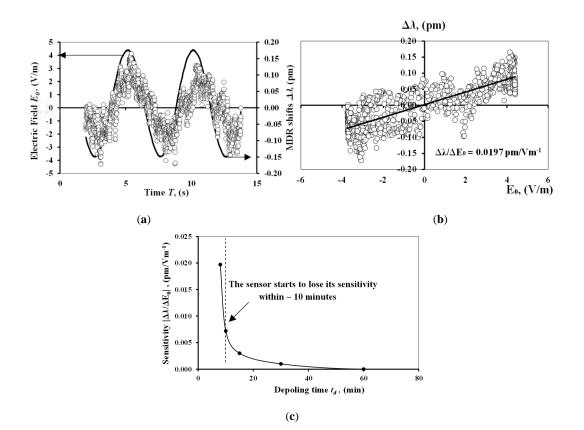


Figure 4. Schematic for the typical preparation for the sensing element in: (**a**) the curing then poling technique (CTP); and (**b**) the curing while poling technique (CWP).

3. Experimental Results

Figure 5a shows the MDR shifts of the homogeneous sphere under a 0.2 Hz harmonic electric field perturbation with a 4 V/m amplitude. The corresponding sensitivity plot of the MDR shift vs. the electric field is presented in Figure 5b. The best fit of the data (solid line) indicates a sensitivity of $\Delta\lambda/\Delta E_0 = 0.0197 \text{ pm/Vm}^{-1}$. The corresponding electric field resolution is ($\Delta E_0/\Delta\lambda$) $\delta\lambda \approx 1.98 \text{ V/m}$. In this case, the standard deviation of the data scatter is $\delta\lambda = 0.039 \text{ pm}$. Although the sensor becomes sufficiently sensitive in the electric field, it starts de-poling after a short period (within ca. 10 min) after poling, hence losing sensitivity, as shown in Figure 5c. This process for running the experiment in this way is called curing-then-poling (CTP). The other technique, using CWP, had the same behavior,



sensitivity, and resolution because it is actually the same sensor, with the only difference between each being the de-poling time.

Figure 5. (a) The time response for the homogeneous sphere under 0.2 Hz harmonic electric field perturbation with 4 V/m amplitude, where $\Delta\lambda$ is the output and the E_0 is the input to the sphere; (b) the calibration curve for the sensor shows the relationship between the output and the input with the slope of the best fit of the data $\Delta\lambda/\Delta E_0 = 0.0197 \text{ pm/Vm}^{-1}$ and shows that the standard deviation of the data scatter is $\delta\lambda = 0.039 \text{ pm}$; and (c) the de-poling time (t_d) for the micro-sphere under harmonic field perturbation fabricated using the curing-then-poling (CTP) method.

In this paper, we present a new method of sensor fabrication in order to mitigate this problem and to lock the polarization of the sensor's material for a longer time with the same sensitivity. Another meethod to fabricate the sensing element should be used. The micro-sphere will be poled and cured simultaneously (curing-while-poling (CWP), refer to Figure 4b). When the previous experiment was repeated, but this time using the CWP method, we obtained almost the same sensitivity for the previous CTP technique, and the sensitivity for the sensing element starts to de-pole from ca. 0.0197 pm/Vm⁻¹ to zero within ca. 6200 min. Chemical changes in the material of the sensing element caused by this new method of fabrication (CWP) enhanced the sensitivity period. The behavior of the dangling bonds for the partly cured PDMS leads to a two order of magnitude enhancement in the de-poling time, as shown in Figure 6. Additionally, it is clear that the magnitude of the poling affects the behavior of the sensing element under the same condition of the experiment. The higher poling magnitude will sustain the sensor's sensitivity for a longer time, as seen in Figure 7. The sensitivity starts to de-pole within ca. 60 min when it is under a poling magnitude of up to 500 kV/m. However, the same sensing element has a longer de-poling time of ca. 6200 min when poled under 1 MV/m.

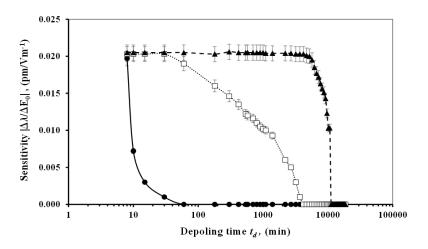


Figure 6. De-poling time; for the micro-sphere under harmonic field perturbation fabricated using the curing-while-poling (CWP) method; where the -- is the curing then poling, -- is the curing while poling in an electric field = 500 kV/m, and -- is the curing while poling in an electric field = 1 MV/m.

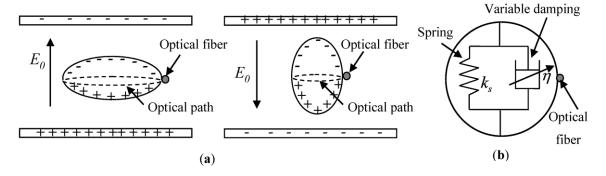


Figure 7. Schematic for (**a**) the effect of the electric field on sphere morphology; and (**b**) the equivalent spring and damper representation for the sphere.

4. Analysis and Discussion

In this paper, a solid dielectric of radius, R, and inductive capacity ε_1 was considered when it was subjected to a uniform electric field E_0 in air, as shown in Figure 1a. The sphere is surrounded by a medium with inductive capacity ε_2 . The external electric field exerts forces on the body of the sphere, f_b , as well as forces on the sphere surface. The deformation of the sphere can be obtained by solving the Navier equation for a steady-state case:

$$\nabla^2 \vec{u} + \frac{1}{1 - 2\nu} \nabla (\nabla \cdot \vec{u}) = -\frac{f_b}{G}$$
⁽²⁾

where \vec{u} is the displacement vector of a given point within the sphere, v and G are Poisson's ratio and shear modulus of the sphere material, respectively. Electrostrictive body force induced by an external electric field is given by [9,13]:

$$\vec{f}_b = -\frac{1}{2}\vec{E}^2 \nabla \varepsilon_1 - \frac{1}{4}(a_1 + a_2) \nabla \vec{E}^2$$
(3)

where E is the electric field within the sphere, ε_1 is the dielectric constant, and a_1 and a_2 are coefficients that describe the electro-elastic properties of the sphere material. The parameters a_1 and a_2 represent the dependence of dielectric constant ε_1 on mechanical strain in the directions parallel and normal to the electric field direction, respectively. The sphere rests on between the two electrodes as shown in Figure 7a and the electric field generated by connecting these two electrodes with a function generator.

In Figure 7b, the sphere could modeled as a linear spring with variable damper to be easily represented as a first order system as shown in the next equation:

$$\frac{\eta}{k_s} \frac{d\gamma(t)}{dt} + \gamma(t) = \frac{b_0}{k_s} F(t)$$

$$\tau \frac{d\gamma(t)}{dt} + \gamma(t) = KF(t)$$
(4)

where K, τ , η , and k_s are the static sensitivity, sensor's time constant, variable damping coefficient, and the linear stiffness coefficient, respectively. Additionally, F(t) is the input force on the sphere in this case it could be the electrostrictive body force and $\gamma(t)$ is the output deformation of the sphere.

When the micro-sphere poled and cured simultaneously curing-while-poling (CWP) or cured-then-poled (CTP) as seen in Figure 6, it seems that the sensitivity sooner or later needs to drop to the steady-state point (zero level). A situation like this is similar to first-order systems under step input. Then the solution for such a system is given by:

$$\gamma(t) = K f_s \left[1 - e^{\frac{-t}{\tau}} \right]$$
(5)

It is clear that when the time constant for the sensor, τ , is high; so the longer time will take to reach the steady-state point (zero level). On the other hand, the de-poling time which is represented by, t_d , will directly proportional with the time constant of the sensor, τ , where the time constant of the sensor τ is governed by the ratio of the damping coefficient η to the stiffness coefficient k_s for the sensor.

Since, this paper presents a new method of fabrication for the sensing elements called curing-while-poling (CWP) method versus the cured-then-poled (CTP), we created a polymeric sheet from the same mixtures that we made the sensors from. Then we test it using coefficient thermal expansion (CTE) determination. The application of the dependence of CTE on temperature method makes it possible to determine the geometrical dimension changes and the character structure changes. A CTE determination experiment was run on an electrical dilatometer. CTE determination was carried out for all CTP and CWP sensor fabrication methods.

In Figure 8 we can see that CTE obtains a negative value at T = 55-75 °C. This means that there are dangling bonds; therefore, the material is partly cured [35]. Sensors that cured without voltage have large quantities of dangling bonds, as well as areas of sharp energy absorption (jump) in the initial stage of cure continuation. For sensors cured in an electric field we can see this phenomenon in the final stage, which is evidence of polymer structural change.

A comparison among the thermal expansion coefficients α in the case of CTP and CWP under 500 kV/m, and CWP under 1 MV/m were made. It becomes clear that the α for CWP under 1 MV/m is higher than CWP under 500 kV/m, and is higher than CTP. Since there is expansion due to the temperature change (ΔT) caused by thermal strain, ε_T , and given by $\varepsilon_T = \alpha(\Delta T)$, by applying Hooke's law we can relate the thermal strain, ε_T , to the modulus of elasticity (E_s) as shown in Equation (6):

$$\varepsilon_T = \alpha \left(\Delta T\right) = \frac{\sigma}{E_s} = \frac{\sigma A}{2k_s R}$$
(6)

where σ and A are the normal stress due to thermal expansion and the cross-sectional area for the sensor. An inversely proportional relationship can be seen between the thermal expansion coefficient α and the stiffness coefficient k_s for the sensor, as revealed by Equation (6). Figure 8 proves that the CWP will increase the value for the thermal expansion coefficient and then decrease the stiffness coefficient of the sensors compared to the CTP. Thus, the time constant for the sensor, τ , will be enhanced significantly. In turn, the de-poling time for the sensor will be increased as well, and that matches with the experimental results shown in Figure 6.

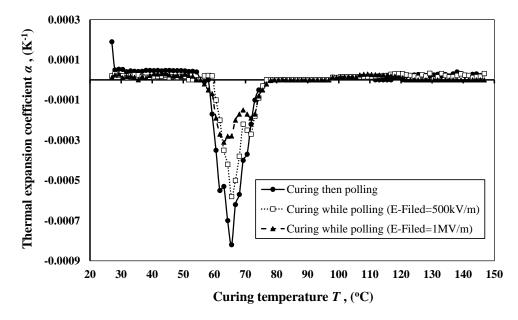


Figure 8. Dependence of CTE on the CTP and CWP sensor fabrication methods.

5. Conclusions

An electric field optical sensor with long duration of sensitivity was demonstrated in this paper. The experiments were carried out by using two different fabrication techniques: cured-then-poled (CTP) and curing-while-poling (CWP). The coefficient thermal expansion (CTE) determination was analyzed for both fabrication techniques. The sensor fabricated by the (CTP process) showed a constant sensitivity of $\Delta\lambda/\Delta E_0 = 0.0197 \text{ pm/Vm}^{-1}$ and corresponding electric field resolution was ($\Delta E_0/\Delta\lambda$) $\delta\lambda \approx 1.98 \text{ V/m}$. Although the sensor does become sufficiently sensitive to electric fields, it starts de-poling after a short period (within ~10 min) after poling, hence losing sensitivity very quickly. On the other hand, the sensor fabricated by the new technique (CWP process) showed almost the same sensitivity, but starts de-poling after a long period (within ca. 6200 min). Just using this new fabrication technique enhanced the duration for the sensor sensitivity by two orders of magnitude. Due to the thermal expansion coefficient increased when we used the CWP compared to the CTP. In turn, the time constant for the sensor enhanced significantly by the same order. Thus, the de-poling time for the sensor increased, as well and that is exactly matching with the experimental results.

Author Contributions: The manuscript was written using the contributions of all authors. Amir R. Ali and Roushdy A. Ali designed the experiments; Amir R. Ali performed the experiments; Amir R. Ali, Amal S. Tourky and Roushdy A. Ali analyzed the data; and Amir R. Ali, Amal S. Tourky wrote the paper. All authors have given approval to the final version of the manuscript.

Conflicts of Interest: The authors declare no conflicts of interest.

References

- Serpengüzel, A.; Arnold, S.; Griffel, G. Excitation of resonances of microspheres on an optical fiber. *Opt. Lett.* 1995, 20, 654–656. [CrossRef] [PubMed]
- 2. Rosenberger, A.T.; Rezac, J.P. Whispering-gallerymode evanescent-wave microsensor for trace-gas detection. *Proc. SPIE* **2001**, *4265*, 102–112.
- Das, N.; Ioppolo, T.; Ötügen, V. Investigation of a micro-optical concentration sensor concept based on whispering gallery mode resonators. In Proceedings of the 45th AIAA Aerospace Sciences Meeting and Exhibition, Reno, NV, USA, 8–11 January 2007.
- 4. Guan, G.; Arnold, S.; Ötügen, M.V. Temperature Measurements Using a Micro-Optical Sensor Based on Whispering Gallery Modes. *AIAA J.* **2006**, *44*, 2385–2389. [CrossRef]

- 5. Roll, G.; Schweiger, G. Geometrical optics model of Mie resonances. J. Opt. Soc. Am. A. 2000, 17, 1301–1311. [CrossRef]
- 6. Roll, G.; Kaiser, T.; Lange, S.; Schweiger, G. Ray interpretation of multipole fields in spherical dielectric cavities. *J. Opt. Soc. Am. A.* **1998**, *15*, 2879–2891. [CrossRef]
- Gorodetsky, M.L.; Savchenkov, A.A.; Ilchenko, V.S. Ultimate *Q* of optical microsphere resonators. *Opt. Lett.* 1996, 21, 453–455. [CrossRef] [PubMed]
- 8. Griffel, G.; Arnold, S.; Taskent, D.; Serpengüzel, A.; Connolly, J.; Morris, N. Morphology-dependent resonances of a microsphere–optical fiber system. *Opt. Lett.* **1996**, *21*, 695–697. [CrossRef] [PubMed]
- 9. Ali, A.R.; Kamel, M.A. Mathematical model for electric field sensor based on whispering gallery modes using Navier's equation for linear elasticity. *J. Math. Probl. Eng.* **2017**, 2017, 9649524. [CrossRef]
- Ali, A.R.; Kamel, M.A. Novel techniques for optical sensor using single core multilayer structures for electric field detection. In Proceedings of the SPIE Optics & Optoelectronics, Prague, Czech Republic, 24–27 April 2017.
- 11. Ali, A.R.; Ioppolo, T.; Ötügen, V.; Christensen, M.; MacFarlane, D. Photonic electric field sensor based on polymeric microspheres. *J. Polym. Sci. Part B Polym. Phys.* **2014**, *52*, 276–279. [CrossRef]
- 12. Ioppolo, T.; Ötügen, M.V.; Ayaz, U.K. Development of whispering gallery mode polymeric micro-optical electric field sensors. *J. Vis. Exp.* **2013**, e50199. [CrossRef] [PubMed]
- 13. Ioppolo, T.; Stubblefield, J.; Ötügen, M.V. Electric field-induced deformation of polydimethylsiloxane polymers. *J. Appl. Phys.* **2012**, *112*, 044906. [CrossRef]
- 14. Gluckman, B.J.; Nguyen, H.; Weinstein, S.L.; Schiff, S.J. Adaptive Electric Field Control of Epileptic Seizures. *J. Neurosci.* **2001**, *21*, 590–600. [CrossRef] [PubMed]
- 15. Ioppolo, T.; Ayaz, U.K.; Ötügen, M.V. High-resolution force sensor based on morphology dependent optical resonances of polymeric spheres. *J. Appl. Phys.* **2009**, *105*, 013535. [CrossRef]
- 16. Ali, A.R.; Ioppolo, T.; Ötügen, M.V. High-resolution electric field sensor based on whispering gallery modes of a beam-coupled dielectric resonator. In Proceedings of the 2012 International Conference on Engineering and Technology (ICET), Cairo, Egypt, 10–11 October 2012.
- 17. Ayaz, U.; Ioppolo, T.; Ötügen, M.V. Wall shear stress sensor based on the optical resonances of dielectric microspheres. *Meas. Sci. Technol.* **2011**, *22*, 075203. [CrossRef]
- 18. Serpengüzel, A.; Arnold, S.; Griffel, G.; Lock, J.A. Enhanced coupling to microsphere resonances with optical fibers. *J. Opt. Soc. Am. B* **1997**, *14*, 790–795. [CrossRef]
- 19. Foreman, M.R. Single-particle Spectroscopy: Whispers of absorption. *Nat. Photonics* **2016**, *10*, 755–757. [CrossRef]
- 20. Klitzing, W.V. Tunable whispering modes for spectroscopy and CQED Experiments. *New J. Phys.* 2001, *3*, 14:1–14:14. [CrossRef]
- 21. Cai, M.; Painter, O.; Vahala, K.J.; Sercel, P.C. Fiber-coupled microsphere laser. *Opt. Lett.* **2000**, *25*, 1430–1432. [CrossRef] [PubMed]
- 22. Tapalian, H.C.; Laine, J.P.; Lane, P.A. Thermooptical switches using coated microsphere resonators. *IEEE Photonics Technol. Lett.* 2002, *14*, 1118–1120. [CrossRef]
- 23. Little, B.E.; Chu, S.T.; Haus, H.A.; Foresi, J.; Laine, J.P. Microring resonator channel dropping filters. *J. Lightwave Technol.* **1997**, *15*, 998–1005. [CrossRef]
- Offrein, B.J.; Germann, R.; Horst, F.; Salemink, H.W.M.; Beyerl, R.; Bona, G.L. Resonant coupler-based tunable add-after-drop filter in silicon-oxynitride technology for WDM networks. *IEEE J. Sel. Top. Quantum Electron.* 1999, 5, 1400–1406. [CrossRef]
- 25. Ali, A.R.; Elias, C.M. Ultra-sensitive optical resonator for organic solvents detection based on whispering gallery modes. *Chemosensors* **2017**, *5*, 19. [CrossRef]
- 26. Ali, A.R. Development of Whispering Gallery Mode Polymeric Micro-optical Sensors to Detect Chemical Impurities in Water Environment. *Sci. Pages Photonics Opt.* **2017**, *1*, 7–15.
- Ali, A.R.; Massoud, Y.M. Bio-optical sensor for brain activity measurement based on whispering gallery modes. In Proceedings of the SPIE Micro Technologies, Barcelona, Spain, 8–10 May 2017.
- 28. Ali, A.R.; Afifi, A.N.; Taha, H. Optical signal processing and tracking of whispering gallery modes in real time for sensing applications. In Proceedings of the SPIE Micro Technologies, Barcelona, Spain, 8–10 May 2017.
- 29. Ali, A.R.; Erian, A.; Shokry, K. Computational model and simulation for the whispering gallery modes inside micro-optical cavity. In Proceedings of the SPIE Micro Technologies, Barcelona, Spain, 8–10 May 2017.

- Ali, A.R.; Gatherer, A.; Ibrahim, M.S. Spinning optical resonator sensor for torsional vibrational applications measurements. In Proceedings of the SPIE LASE International Society for Optics and Photonics, San-Francisco, CA, USA, 22 April 2016.
- 32. Matsko, A.B.; Savchenkov, A.A.; Strekalov, D.; Ilchenko, V.S.; Maleki, L. Review of application of whispring-gallery mode resonators in photonics and nonlinear optics. *IPN Prog. Rep.* 2005, 42–162, 1–51.
- Huston, A.L.; Eversole, J.D. Strain-sensitive elastic scattering from cylinders. *Opt. Lett.* 1993, 18, 1104–1106. [CrossRef] [PubMed]
- 34. Knight, J.C.; Cheung, G.; Jacques, F.; Birks, T.A. Phase-matched excitation of whispering-gallery-mode resonances by a fiber taper. *Opt. Lett.* **1997**, *22*, 1129–1131. [CrossRef] [PubMed]
- 35. Lemke, B.P.; Haneman, D. Dangling bonds on silicon. Phys. Rev. B 1978, 17, 1893. [CrossRef]



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